

**Notice of References Cited**

Application/Control No.

10/676,312

Applicant(s)/Patent Under  
Reexamination  
PAN ET AL.

Examiner

VINCE E. KOVALICK

Art Unit

2629

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*	B	US-2002/0024017	02-2002	Overdick et al.	250/370.11
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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